# **Power MOSFET** 30 V, 88 A, Single N–Channel, DPAK/IPAK

#### Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### Applications

- CPU Power Delivery
- DC–DC Converters
- Low Side Switching

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Param	Parameter				Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	30	V
Gate-to-Source Voltag	e		V <sub>GS</sub>	±20	V
Continuous Drain		$T_A = 25^{\circ}C$	Ι <sub>D</sub>	17.4	Α
Current (R <sub>0JA</sub> ) (Note 1)		$T_A = 85^{\circ}C$		13.5	
Power Dissipation $(R_{\theta JA})$ (Note 1)		$T_A = 25^{\circ}C$	PD	2.65	W
Continuous Drain		$T_A = 25^{\circ}C$	۱ <sub>D</sub>	12.7	Α
Current ( $R_{\theta JA}$ ) (Note 2)	Steady	$T_A = 85^{\circ}C$		9.8	
Power Dissipation $(R_{\theta JA})$ (Note 2)	State	$T_A = 25^{\circ}C$	P <sub>D</sub>	1.41	W
Continuous Drain		$T_C = 25^{\circ}C$	۱ <sub>D</sub>	95	Α
Current (R <sub>θJC</sub> ) (Note 1)		$T_{\rm C} = 85^{\circ}{\rm C}$		73	
Power Dissipation $(R_{\theta JC})$ (Note 1)		$T_C = 25^{\circ}C$	PD	79	W
Pulsed Drain Current	t <sub>p</sub> =10μs	T <sub>A</sub> = 25°C	I <sub>DM</sub>	175	Α
Current Limited by Pack	age	$T_A = 25^{\circ}C$	I <sub>DmaxPkg</sub>	45	А
Operating Junction and	Storage Te	emperature	T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	°C
Source Current (Body D	iode)		۱ <sub>S</sub>	55	А
Source Current (Body D	iode) Pulse	ed t <sub>p</sub> =20 μs	I <sub>SM</sub>	175	А
Drain to Source dV/dt			dV/dt	6.0	V/ns
Single Pulse Drain-to-Source Avalanche Energy (V <sub>DD</sub> = 24 V, V <sub>GS</sub> = 10 V, L = 1.0 mH, I <sub>L(pk)</sub> = 24 A, R <sub>G</sub> = 25 $\Omega$ )			E <sub>AS</sub>	288	mJ
Lead Temperature for So (1/8" from case for 10 s)	Idering Pu	rposes	ΤL	260	°C

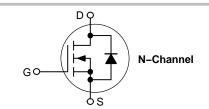
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

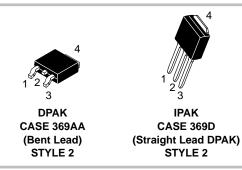


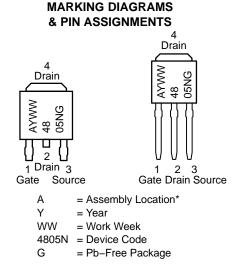
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#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX	
30 V	5.0 mΩ @ 10 V	88 A	
30 V	7.4 mΩ @ 4.5 V	00 A	







\* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 6 of this data sheet.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ ext{ heta}JC}$	1.9	°C/W
Junction-to-TAB (Drain)	$R_{\thetaJC-TAB}$	3.5	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	56.6	
Junction-to-Ambient - Steady State (Note 2)	$R_{ hetaJA}$	106.6	

Surface-mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I	<sub>D</sub> = 250 μA	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				27		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$			1.0	μΑ
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V	<sub>GS</sub> = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS},$	<sub>D</sub> = 250 μA	1.5		2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.86		mV/°C

Negative Threshold Temperature Coefficient	$V_{GS(TH)}/T_J$			5.86		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10$ to	I <sub>D</sub> = 30 A	4.3	5.0	mΩ
		11.5 V	I <sub>D</sub> = 15 A	4.2		
		$V_{GS}$ = 4.5 V	I <sub>D</sub> = 30 A	6.0	7.4	
			I <sub>D</sub> = 15 A	5.8		
Forward Transconductance	9fs	V <sub>DS</sub> = 15 V,	I <sub>D</sub> = 15 A	17		S

#### CHARGES AND CAPACITANCES

Input Capacitance	C <sub>iss</sub>		2865		pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 12 V	610		
Reverse Transfer Capacitance	C <sub>rss</sub>		338		
Total Gate Charge	Q <sub>G(TOT)</sub>		20.5	26	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V,	4.05		
Gate-to-Source Charge	Q <sub>GS</sub>	I <sub>D</sub> = 30 A	8.28		
Gate-to-Drain Charge	Q <sub>GD</sub>		8.36		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = 11.5 V, $V_{DS}$ = 15 V, $I_{D}$ = 30 A	48		nC

#### SWITCHING CHARACTERISTICS (Note 4)

Turn-On Delay Time	t <sub>d(on)</sub>		17.2	ns
Rise Time	t <sub>r</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 15 V,	20.3	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D$ = 15 A, $R_G$ = 3.0 $\Omega$	20.8	
Fall Time	t <sub>f</sub>		8.0	
Turn–On Delay Time	t <sub>d(on)</sub>		10.8	ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 11.5 V, V <sub>DS</sub> = 15 V,	20.5	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D$ = 15 A, $R_G$ = 3.0 $\Omega$	30.8	
Fall Time	t <sub>f</sub>		4.4	

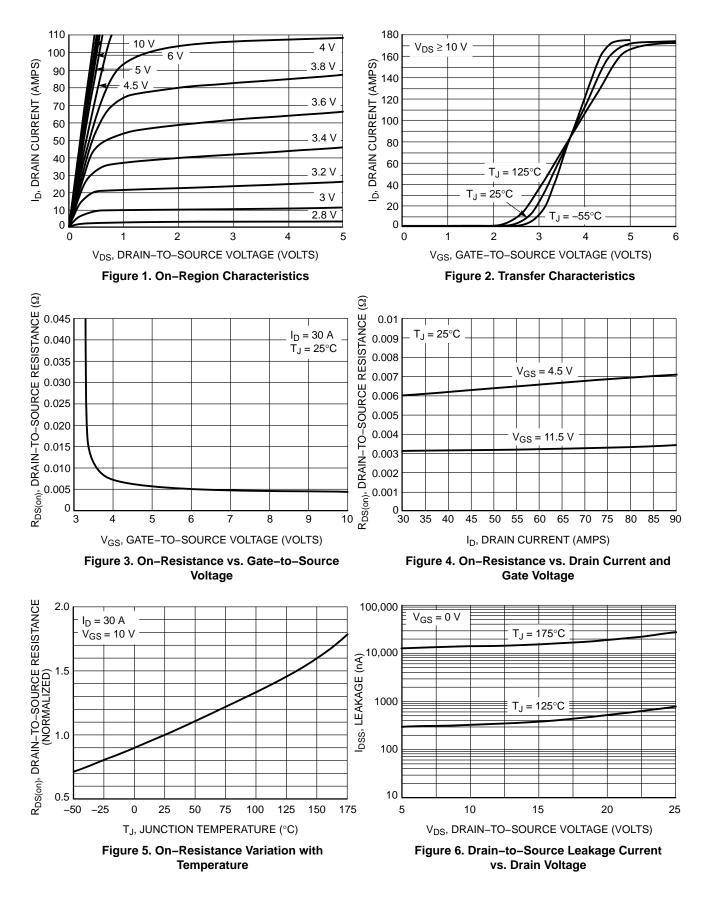
#### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted) (continued)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit			
DRAIN-SOURCE DIODE CHARACTERISTICS										
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.87	1.2	V			
		I <sub>S</sub> = 30 A	T <sub>J</sub> = 125°C		0.76		1			
Reverse Recovery Time	t <sub>RR</sub>				25.7		ns			
Charge Time	ta	$V_{GS} = 0 V, dls/$	dt = 100 A/μs,		13.1		1			
Discharge Time	tb	I <sub>S</sub> = 3	I <sub>S</sub> = 30 A		12.6		1			
Reverse Recovery Time	Q <sub>RR</sub>				18		nC			
PACKAGE PARASITIC VALUES							•			

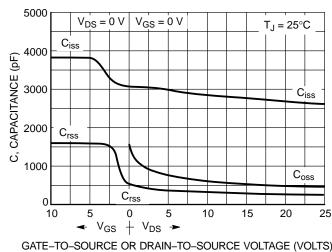
Source Inductance	L <sub>S</sub>		2.49	nH
Drain Inductance, DPAK	L <sub>D</sub>		0.0164	
Drain Inductance, IPAK	L <sub>D</sub>	T <sub>A</sub> = 25°C	1.88	
Gate Inductance	L <sub>G</sub>		3.46	
Gate Resistance	R <sub>G</sub>		0.8	Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 3. Pulse Test: Pulse Width  $\leq$  300 µs, Duty Cycle  $\leq$  2%. 4. Switching characteristics are independent of operating junction temperatures.

### **TYPICAL PERFORMANCE CURVES**



#### **TYPICAL PERFORMANCE CURVES**





1000

100

10

1

1000

100

1

t, TIME (ns)



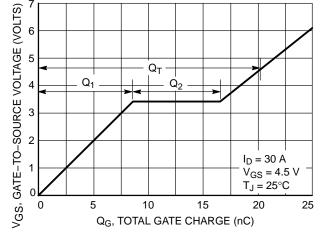
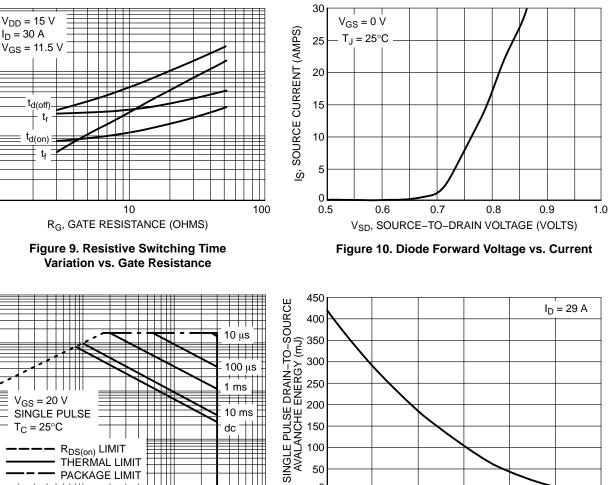
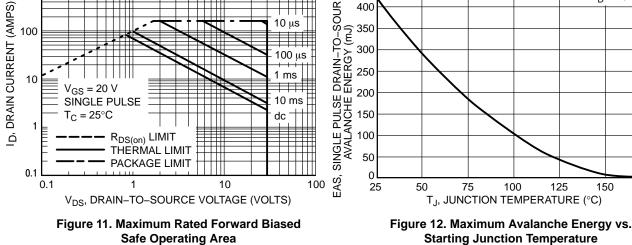


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

175





#### **TYPICAL PERFORMANCE CURVES**

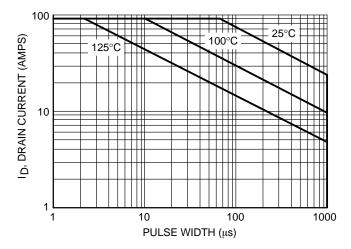
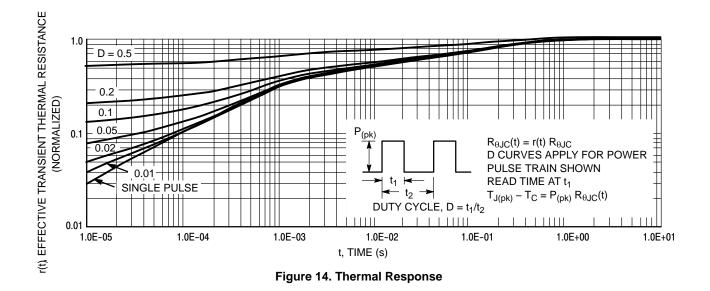


Figure 13. Avalanche Characteristics



#### **ORDERING INFORMATION**

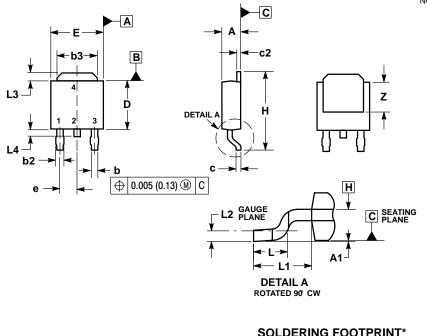
Order Number	Package	Shipping <sup>†</sup>
NTD4805NT4G	DPAK (Pb–Free)	2,500 / Tape & Reel
NTD4805N-1G	IPAK (Pb–Free)	75 Units / Rail
NVD4805NT4G*	DPAK (Pb–Free)	2,500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

\*NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC–Q101 Qualified and PPAP Capable.

#### PACKAGE DIMENSIONS

DPAK (SINGLE GUAGE) CASE 369AA **ISSUE B** 



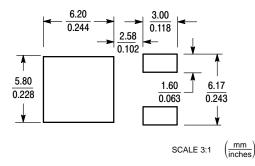
- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: INCHES.
  3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS D3, L3 and Z.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
  5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
  6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- PLANE H.

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
c	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
Е	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29 BSC	
Н	0.370	0.410	9.40	10.41
Г	0.055	0.070	1.40	1.78
L1	0.108 REF		2.74	REF
L2	0.020	0.020 BSC 0.51 B		BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Ζ	0.155		3.93	

**SOLDERING FOOTPRINT\*** 

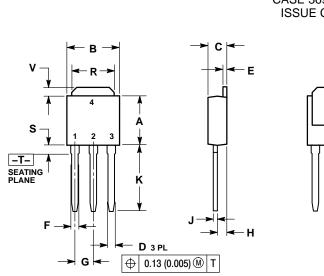


STYLE 2:

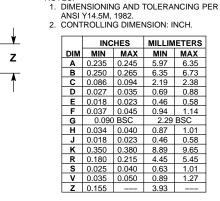


\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS







6.35

6.73

2.38

0.88

0.58

1.14

0.58

9.65

5.45

1.01

1.27

1.01

2.29 BSC

NOTES

STYLE 2: PIN 1. GATE 2. DRAIN SOURCE 3. 4. DRAIN

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